

# STV250N55F3

## N-channel 55 V, 1.5 mΩ, 250 A, PowerSO-10 STripFET<sup>™</sup> Power MOSFET

### **Features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	Ι <sub>D</sub>
STV250N55F3	55 V	< 2.2 mΩ	250 A

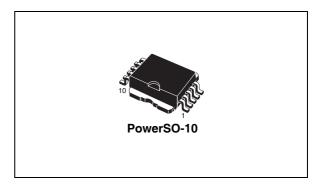
- Conduction losses reduced
- Low profile, very low parasitic inductance

## Application

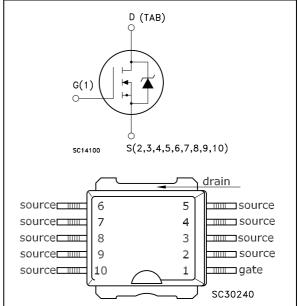
Switching applications

## Description

This n-channel enhancement mode Power MOSFET is the latest refinement of STMicroelectronics unique "single feature size" strip-based process with less critical alignment steps and therefore a remarkable manufacturing reproducibility. The resulting transistor shows extremely high packing density for low onresistance, rugged avalanche characteristics and low gate charge.



#### Figure 1. Internal schematic diagram and connection diagram (top view)



#### Table 1. **Device summary**

Order code	Marking	Package	Packaging
STV250N55F3	250N55F3	PowerSO-10	Tape and reel

November	2008
11010111001	-000

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# 1 Electrical ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage (v <sub>gs</sub> = 0)	55	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
۱ <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	250	Α
۱ <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	175	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	1000	A
P <sub>TOT</sub> <sup>(2)</sup>	Total dissipation at $T_{C}$ = 25 °C	300	w
	Derating factor	2.0	W/°C
E <sub>AS</sub> <sup>(3)</sup>	Single pulse avalanche energy	1	J
T <sub>stg</sub>	Storage temperature	-55 to 175	ာိ
Тj	Operating junction temperature	-55 10 175	

1. Pulse width limited by safe operating area

2. This value is rated according to Rthj-c

3. Starting Tj = 25 °C,  $I_D$  = 60 A,  $V_{DD}$  = 35 V

	Table	3.	Thermal	data
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Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case Max	0.5	°C/W
Rthj-pcb <sup>(1)</sup>	Thermal resistance junction-pcb Max	50	°C/W

1. When mounted on 1 inch<sup>2</sup> FR-4 2 oz Cu



# 2 Electrical characteristics

(T<sub>case</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_{\rm D} = 250 \ \mu \text{A}, \ V_{\rm GS} = 0$	55			V
I <sub>DSS</sub>	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS}$ = Max rating, $V_{DS}$ = Max rating, $T_c$ = 125 °C			1 10	μΑ μΑ
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>DS</sub> = ± 20 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2		4	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 75 A		1.5	2.2	mΩ

### Table 4. On /off states

### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz, V <sub>GS</sub> = 0		6800 1450 15		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 44 \text{ V}, I_D = 120 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see Figure 14)		100 30 26		nC nC nC

	•					
Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on delay time Rise time	$V_{DD} = 27.5 \text{ V}, I_D = 60 \text{ A}$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V},$ <i>(see Figure 13)</i>		25 150		ns ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-off delay time Fall time	$V_{DD} = 27.5 \text{ V}, I_D = 60 \text{ A}$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V},$ <i>(see Figure 13)</i>		110 50		ns ns

Table 6.Switching times

### Table 7.Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SD</sub> <sup>(1)</sup>	Source-drain current Source-drain current (pulsed)				250 1000	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 120 A, V <sub>GS</sub> = 0			1.5	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 120 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 35 \text{ V}, \text{ T}_{j} = 150 ^{\circ}\text{C}$ <i>(see Figure 18)</i>		60 110 3.5		ns nC A

1. Pulse width limited by safe operating area

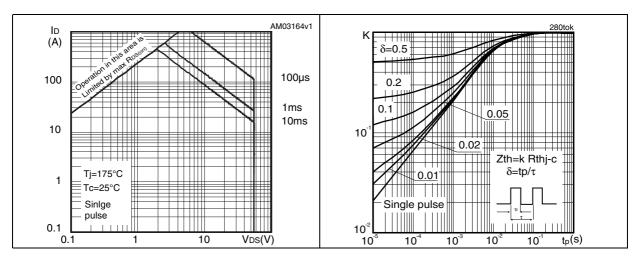
2. Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5%

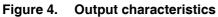


### **Electrical characteristics (curves)** 2.1

#### Safe operating area Figure 2.

Figure 3. Thermal impedance







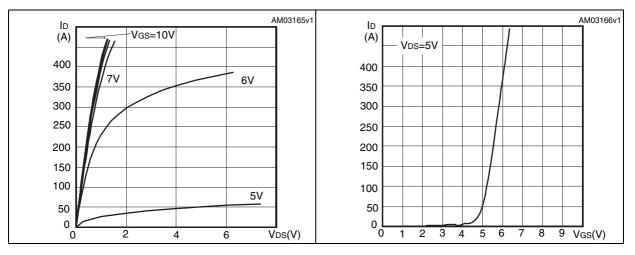
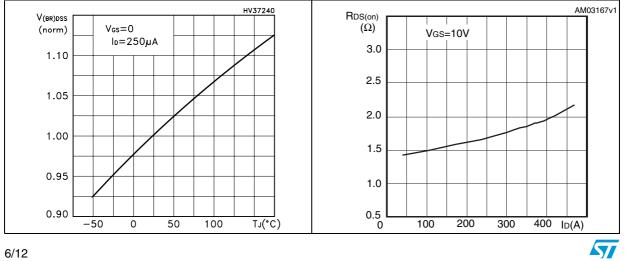
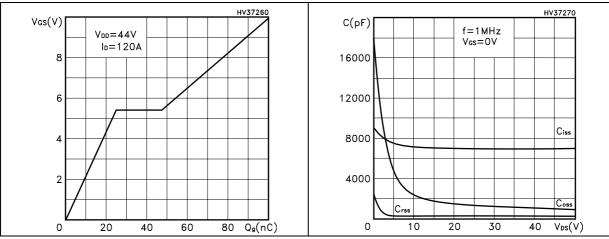




Figure 7. Static drain-source on resistance





### Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage vs temperature

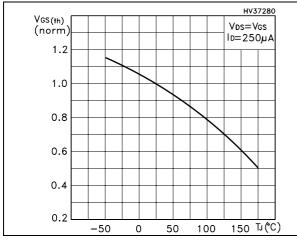
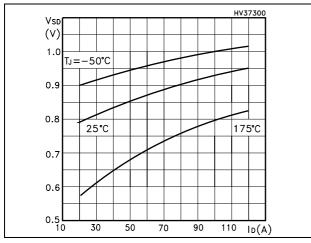


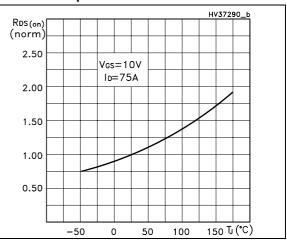
Figure 12. Source-drain diode forward characteristics



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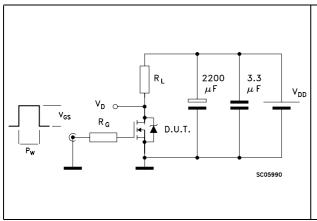
Figure 11. Normalized on resistance vs

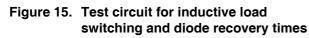


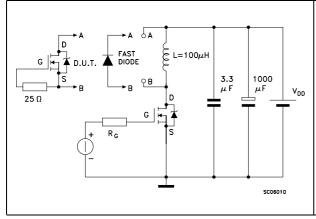


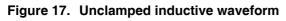
## 3 Test circuits

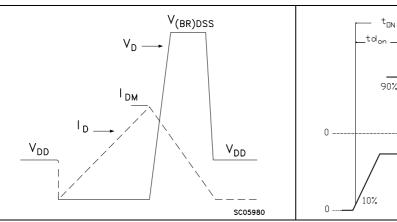
Figure 13. Switching times test circuit for resistive load

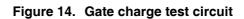


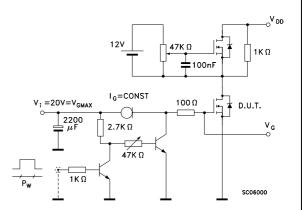


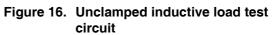












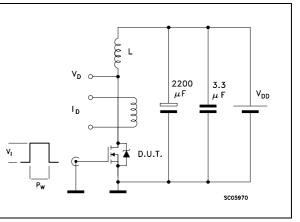
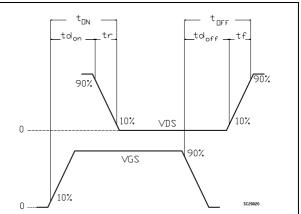


Figure 18. Switching time waveform



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## 4 Package mechanical data

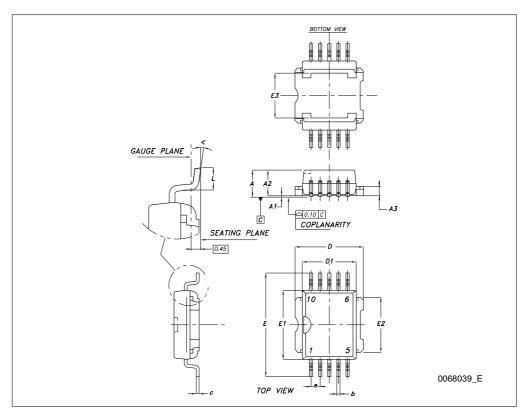
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Dim	mm		
	Min	Тур	Мах
Α			3.70
A1	0.00		0.10
A2	3.40		3.60
A3	1.25		1.35
b	0.40		0.53
С	0.35		0.55
D	9.40		9.60
D1	7.40		7.60
E	13.80		14.40
E1	9.30		9.50
E2	7.20		7.60
E3	5.90		6.10
е		1.27	
L	0.95		1.65
<	0 <sup>0</sup>		8°





# 5 Revision history

### Table 8. Document revision history

Date	Revision	Changes
25-Oct-2007	1	Initial release
20-Mar-2008	2	Content reworked to improve readability, no technical changes.
10-Nov-2008	3	Document status promoted from preliminary data to datasheet.



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